

IRF230 JANTX2N6758 JANTXV2N6758

REPETITIVE AVALANCHE AND dv/dt RATED HEXFET®TRANSISTORS THRU-HOLE (TO-204AA)

200V, N-CHANNEL REF: MIL-PRF-19500/542

Product Summary

Part Number	BV _{DSS}	RDS(on)	I _D	
IRF230	200V	0.40Ω	9.0A	



Description

HEXFET® MOSFET technology is the key to IR Hirel advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high trans conductance; superior reverse energy and diode recovery dv/dt capability.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching and temperature stability of the electrical parameters. They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Features

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- · Hermetically Sealed
- Simple Drive Requirements
- ESD Rating: Class 1C per MIL-STD-750, Method 1020

Absolute Maximum Ratings

Symbol	Parameter	Value	Units
I _{D1} @ V _{GS} = 10V, T _C = 25°C	Continuous Drain Current	9.0	
I _{D2} @ V _{GS} = 10V, T _C = 100°C	Continuous Drain Current	6.0	Α
I _{DM} @T _C = 25°C	Pulsed Drain Current ①	Current ① 36	
P _D @T _C = 25°C	Maximum Power Dissipation	75	W
	Linear Derating Factor	0.6	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy ②	54	mJ
I _{AR}	Avalanche Current ①	9.0	Α
E _{AR}	Repetitive Avalanche Energy ①	7.5	mJ
dv/dt	Peak Diode Recovery ③	5.0	V/ns
T _J	Operating Junction and	-55 to + 150	
T _{STG}	Storage Temperature Range	-55 to + 150	°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	11.5 (Typical)	g

For footnotes refer to the page 2.



Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_{D} = 1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.29		V/°C	Reference to 25°C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.40	Ω	V _{GS} = 10V, I _{D2} = 6.0A ④
				0.49		V _{GS} = 10V, I _{D1} = 9.0A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
I _{DSS}	Zara Cata Valta da Duais Commant			25		V _{DS} = 160V, V _{GS} = 0V
	Zero Gate Voltage Drain Current			250	μA	$V_{DS} = 160V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I_{GSS}	Gate-to-Source Leakage Forward			100	nA	V _{GS} = 20V
	Gate-to-Source Leakage Reverse			-100	IIA	V _{GS} = -20V
Q_G	Total Gate Charge	16		39		$I_{D1} = 9.0A$
Q_{GS}	Gate-to-Source Charge	3.0		5.7	nC	V _{DS} = 100V
Q_{GD}	Gate-to-Drain ('Miller') Charge	8.0		20		V _{GS} = 10V
$t_{d(on)}$	Turn-On Delay Time			35		V _{DD} = 100V
tr	Rise Time			80	no	$I_{D1} = 9.0A$
$t_{d(off)}$	Turn-Off Delay Time			60	ns	$R_G = 7.5\Omega$
t_f	Fall Time			40		$V_{GS} = 10V$
Ls +L _D	Total Inductance		6.1		n⊔	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package)
C _{iss}	Input Capacitance		600			V _{GS} = 0V
C _{oss}	Output Capacitance		250		pF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		80			f = 1.0 MHz

Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
I _S	Continuous Source Current (Body Diode)			9.0	۸	
I _{SM}	Pulsed Source Current (Body Diode) ①			36	Α	
V_{SD}	Diode Forward Voltage			1.4	V	$T_J = 25^{\circ}C, I_S = 9.0A, V_{GS} = 0V$
t _{rr}	Reverse Recovery Time			500	ns	$T_J = 25^{\circ}C, I_F = 9.0A, V_{DD} \le 30V$
Q _{rr}	Reverse Recovery Charge			6.0	μC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrins	ic turn-c	n time i	s negligib	le (turn-on is dominated by L _S +L _D)

Thermal Resistance

Symbo	ol Parameter	Min.	Тур.	Max.	Units	
$R_{ heta JC}$	Junction-to-Case			1.67	°C/\\/	
$R_{ heta JA}$	Junction-to-Ambient (Typical socket mount)		30	°C/W	

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$ V_{DD} = 50V, starting T_J = 25°C, L= 1.33mH, Peak I_L = 9.0A, V_{GS} = 10V.
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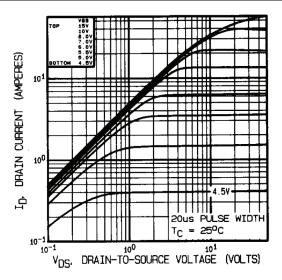


Fig 1. Typical Output Characteristics

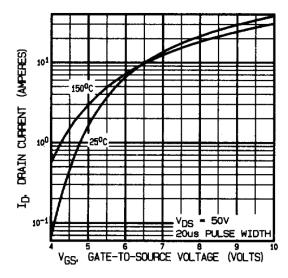


Fig 3. Typical Transfer Characteristics

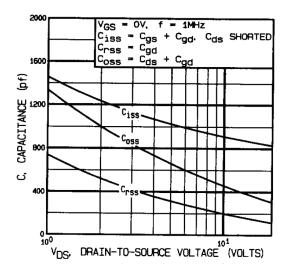


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

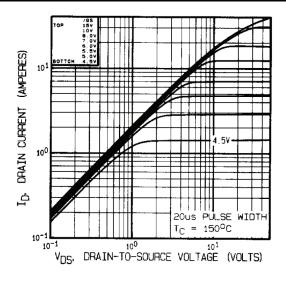


Fig 2. Typical Output Characteristics

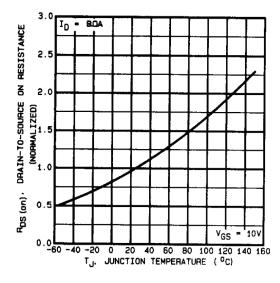


Fig 4. Normalized On-Resistance Vs. Temperature

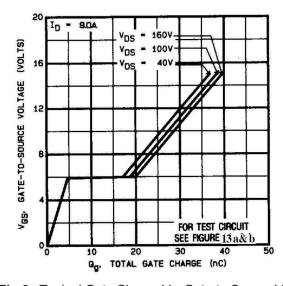


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

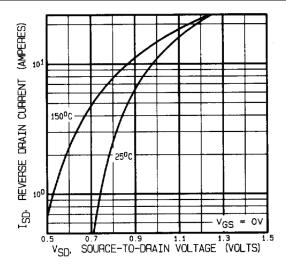


Fig 7. Typical Source-Drain Diode Forward Voltage

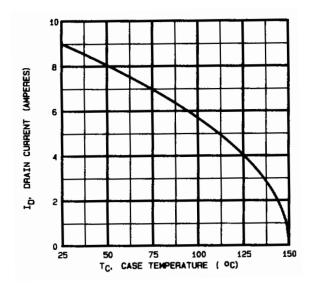


Fig 9. Maximum Drain Current Vs. Case Temperature

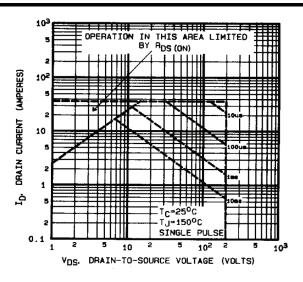


Fig 8. Maximum Safe Operating Area

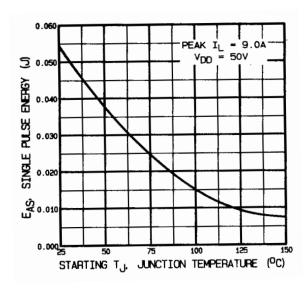


Fig 10. Maximum Avalanche Energy Vs. Drain Current

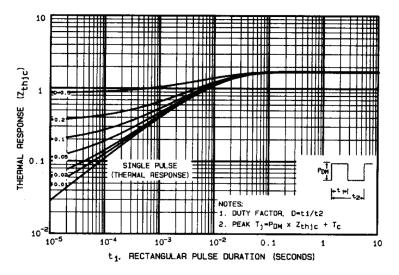


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

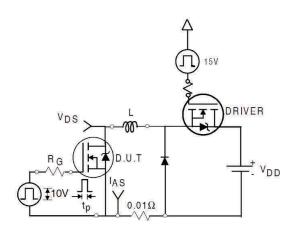


Fig 12a. Unclamped Inductive Test Circuit

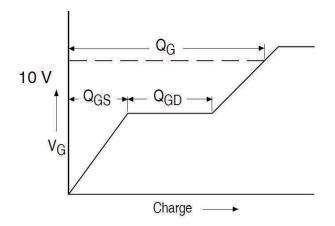


Fig 13a. Gate Charge Waveform

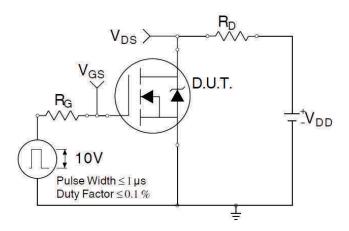


Fig 14a. Switching Time Test Circuit

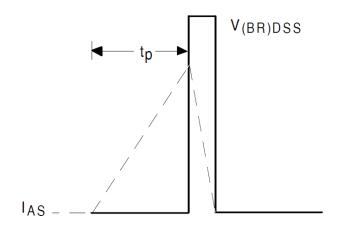


Fig 12b. Unclamped Inductive Waveforms

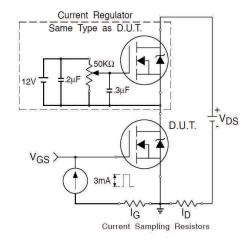


Fig 13b. Gate Charge Test Circuit

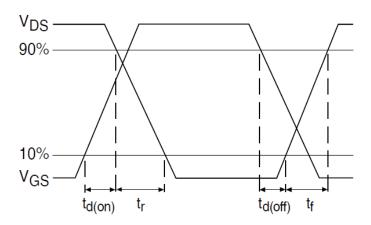
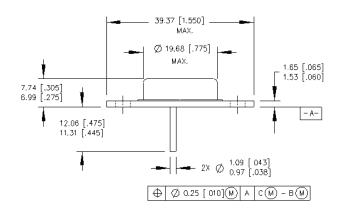
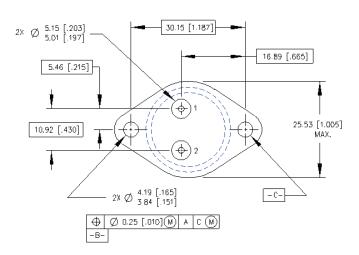


Fig 14b. Switching Time Waveforms



Case Outline and Dimensions - TO-204AA (Modified TO-3)





PIN ASSIGNMENTS

HEXFET SCHOTTKY <u>IGBT</u> 1 - SOURCE 1 - ANODE 1 1 - GATE 2 - GATE 3 - DRAIN (CASE) 2 - EMITTER 3 - COLLECTOR (CASE) 2 - ANODE 2 3 - COMMON CATHOD (CASE)

NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M 1982.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILIMETERS [INCHES]
 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO -204-AA



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